

Search Notes

Application/Control No.

09/538,767

Examiner

Seung H. Lee

Applicant(s)/Patent under
Reexamination

NG, YVONNE

Art Unit

2876

SEARCHED

| Class | Subclass | Date | Examiner |
|-------|----------|-----------|----------|
| 235 | 474 | 5/22/2005 | SHL |
| 235 | 492 | 5/22/2005 | SHL |
| 235 | 375 | 5/22/2005 | SHL |
| 235 | 375 | 5/22/2005 | SHL |
| 235 | 376 | 5/22/2005 | SHL |
| 235 | 380 | 5/22/2005 | SHL |
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INTERFERENCE SEARCHED

| Class | Subclass | Date | Examiner |
|-------|----------|-----------|----------|
| Same | as Above | 5/22/2005 | SHL |
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**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

| | DATE | EXMR |
|------------------|-----------|------|
| EAST | 5/22/2005 | SHL |
| PCT cites | 5/22/2005 | SHL |
| NPL | 5/22/2005 | SHL |
| J. Fureman (235) | 5/22/2005 | SHL |
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